



**FCC 47 CFR PART 15 SUBPART C
INDUSTRY CANADA RSS-210 ISSUE 8**

CERTIFICATION TEST REPORT

FOR

GSM/WCDMA/LTE Phone + Bluetooth, DTS/UNII a/b/g/n/ac, ANT & NFC

MODEL NUMBER: SM-N750S, SM-N750K, SM-N750L

FCC ID: A3LSMN750KOR

IC ID: 649E-SMN750KOR

REPORT NUMBER: 14U17012-7

ISSUE DATE: January 29, 2014

Prepared for

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416, MAETAN 3-DONG, YEONGTONG-GU
SUWON-CITY, GYEONGGI-DO 443-742, SOUTH KOREA**

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NVLAP LAB CODE 200065-0

Revision History

Rev.	Issue Date	Revisions	Revised By
--	1/29/14	Initial Issue	P. Kim

TABLE OF CONTENTS

1. ATTESTATION OF TEST RESULTS.....	4
2. TEST METHODOLOGY	5
3. FACILITIES AND ACCREDITATION.....	5
4. CALIBRATION AND UNCERTAINTY	5
4.1. MEASURING INSTRUMENT CALIBRATION	5
4.2. SAMPLE CALCULATION.....	5
4.3. MEASUREMENT UNCERTAINTY	5
5. EQUIPMENT UNDER TEST	6
5.1. DESCRIPTION OF EUT.....	6
5.2. MAXIMUM OUTPUT POWER.....	6
5.3. WORST-CASE CONFIGURATION AND MODE.....	6
5.4. MODIFICATIONS.....	6
5.5. DESCRIPTION OF TEST SETUP.....	7
6. TEST AND MEASUREMENT EQUIPMENT	10
7. OCCUPIED BANDWIDTH.....	11
8. RADIATED EMISSION TEST RESULTS.....	13
8.1. LIMITS AND PROCEDURE	13
8.1.1. FUNDAMENTAL AND SPURIOUS EMISSIONS (0.15 – 30 MHz)	15
8.1.2. TX SPURIOUS EMISSION 30 TO 1000 MHz	16
9. AC MAINS LINE CONDUCTED EMISSIONS.....	18
10. FREQUENCY STABILITY	22
11. SETUP PHOTOS	23

1. ATTESTATION OF TEST RESULTS

COMPANY NAME: SAMSUNG ELECTRONICS CO., LTD.
416, MAETAN 3-DONG, YEONGTONG-GU
SUWON-CITY, GYEONGGI-DO, 443-742, SOUTH KOREA

EUT DESCRIPTION: GSM/WCDMA/LTE Phone + Bluetooth, DTS/UNII a/b/g/n/ac, ANT & NFC

MODEL: SM-N750S, SM-N750K, SM-N750L

SERIAL NUMBER: FL-029-C (RADIATED)

DATE TESTED: January 24 - 29, 2014

APPLICABLE STANDARDS	
STANDARD	TEST RESULTS
FCC PART 15 SUBPART C	Pass
INDUSTRY CANADA RSS-210 ISSUE 8	Pass
INDUSTRY CANADA RSS-GEN Issue 3	Pass

UL Verification Services Inc. tested the above equipment in accordance with the requirements set forth in the above standards. All indications of Pass/Fail in this report are opinions expressed by UL Verification Services Inc. based on interpretations and/or observations of test results. Measurement Uncertainties were not taken into account and are published for informational purposes only. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

Note: The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. This document may not be altered or revised in any way unless done so by UL Verification Services Inc. and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL Verification Services Inc. will constitute fraud and shall nullify the document. This report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, any agency of the Federal Government, or any agency of any government.

Approved & Released For
UL Verification Services Inc. By:

Tested By:



PHILIP KIM
WISE PROGRAM MANAGER
UL Verification Services Inc.

ROLLY ALEGRE
EMC ENGINEER
UL Verification Services Inc.

2. TEST METHODOLOGY

The tests documented in this report were performed in accordance with ANSI C63.4-2009, FCC CFR 47 Part 2 and FCC CFR 47 Part 15, RSS-GEN Issue 3, and RSS-210 Issue 8.

3. FACILITIES AND ACCREDITATION

The test sites and measurement facilities used to collect data are located at 47173 Benicia Street, Fremont, California, USA.

UL Verification Services Inc. is accredited by NVLAP, Laboratory Code 200065-0. The full scope of accreditation can be viewed at <http://www.ccsemc.com>.

4. CALIBRATION AND UNCERTAINTY

4.1. MEASURING INSTRUMENT CALIBRATION

The measuring equipment utilized to perform the tests documented in this report has been calibrated in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

4.2. SAMPLE CALCULATION

Where relevant, the following sample calculation is provided:

$$\begin{aligned} \text{Field Strength (dBuV/m)} &= \text{Measured Voltage (dBuV)} + \text{Antenna Factor (dB/m)} + \\ &\text{Cable Loss (dB)} - \text{Preamplifier Gain (dB)} \\ 36.5 \text{ dBuV} + 18.7 \text{ dB/m} + 0.6 \text{ dB} - 26.9 \text{ dB} &= 28.9 \text{ dBuV/m} \end{aligned}$$

4.3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus:

PARAMETER	UNCERTAINTY
Conducted Disturbance, 0.15 to 30 MHz	3.52 dB
Radiated Disturbance, 30 to 18000 MHz	4.94 dB

Uncertainty figures are valid to a confidence level of 95%.

5. EQUIPMENT UNDER TEST

5.1. DESCRIPTION OF EUT

This is a GSM/WCDMA/LTE Phone + Bluetooth, DTS/UNII a/b/g/n/ac, ANT & NFC

5.2. MAXIMUM OUTPUT POWER

The testing was performed at 1 meters. The transmitter maximum E-field at 30m distance is 8.57 dBuV/m which convert from the 1 meters data.

5.3. WORST-CASE CONFIGURATION AND MODE

The NFC function was tested at its' fundamental and only operational frequency of 13.56 MHz. The fundamental of the EUT was investigated in three orthogonal orientations X, Y and Z. It was determined that the Z-orientation was the worst-case orientation; therefore all final radiated testing was performed with the EUT in the Z-orientation while generating continuous emissions.

5.4. MODIFICATIONS

No modifications were made during testing.

5.5. DESCRIPTION OF TEST SETUP

SUPPORT EQUIPMENT

Radiated Emissions Above 30 MHz, AC Line Conducted Emissions and Frequency Stability:

Support Equipment List				
Description	Manufacturer	Model	Serial Number	FCC ID
AC Adapter	Samsung	N/A	N/A	N/A
Earphone	Samsung	N/A	N/A	N/A

I/O CABLES

Radiated Emissions above 30 MHz, AC Line Conducted Emissions :

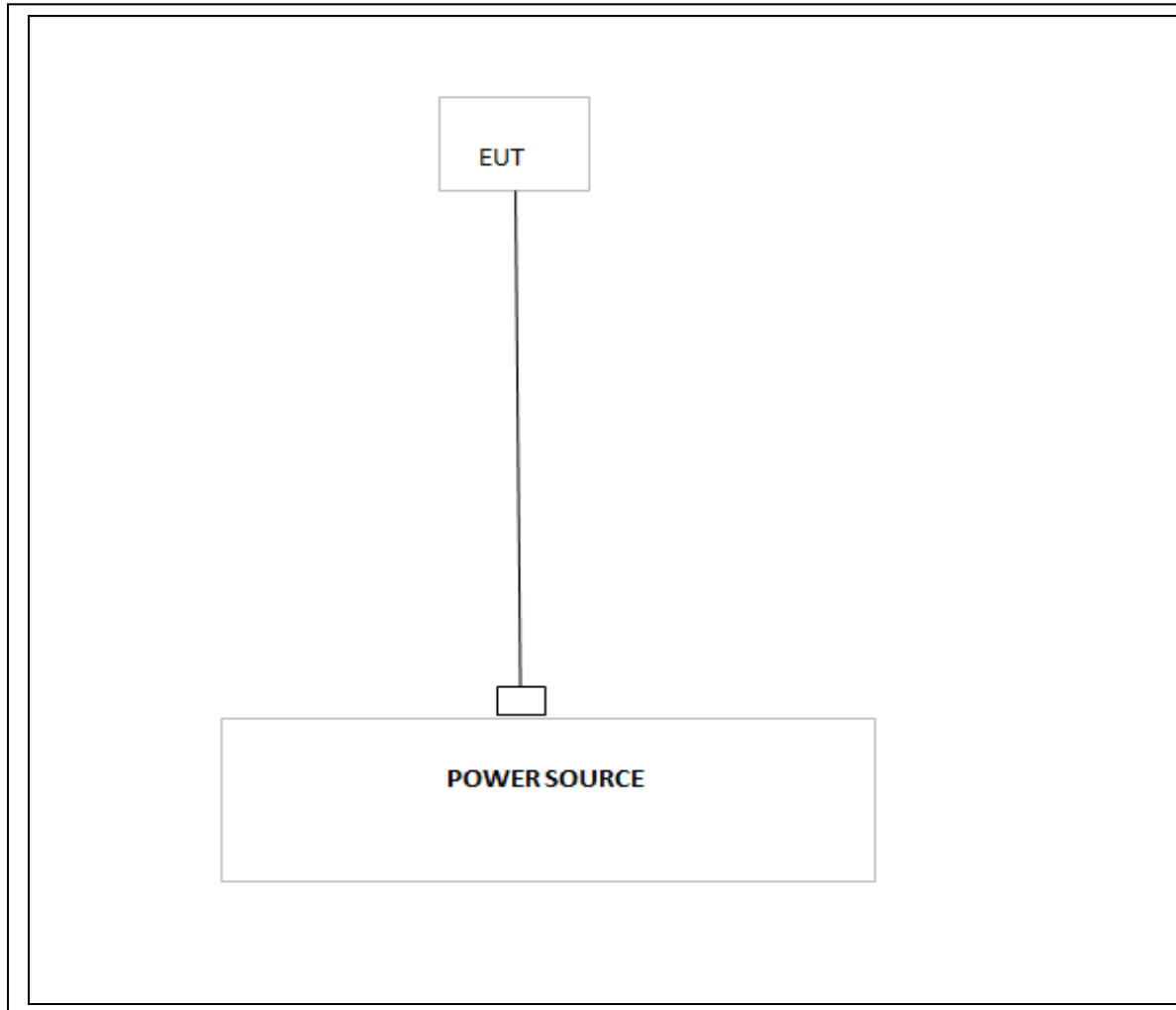
I/O Cable List						
Cable No	Port	# of identical ports	Connector Type	Cable Type	Cable Length (m)	Remarks
1	DC Power	1	Micro-USB	Shielded	1 m	None
2	Audio	1	Mini-Jack	Un-Shielded	1 m	None

TEST SETUP

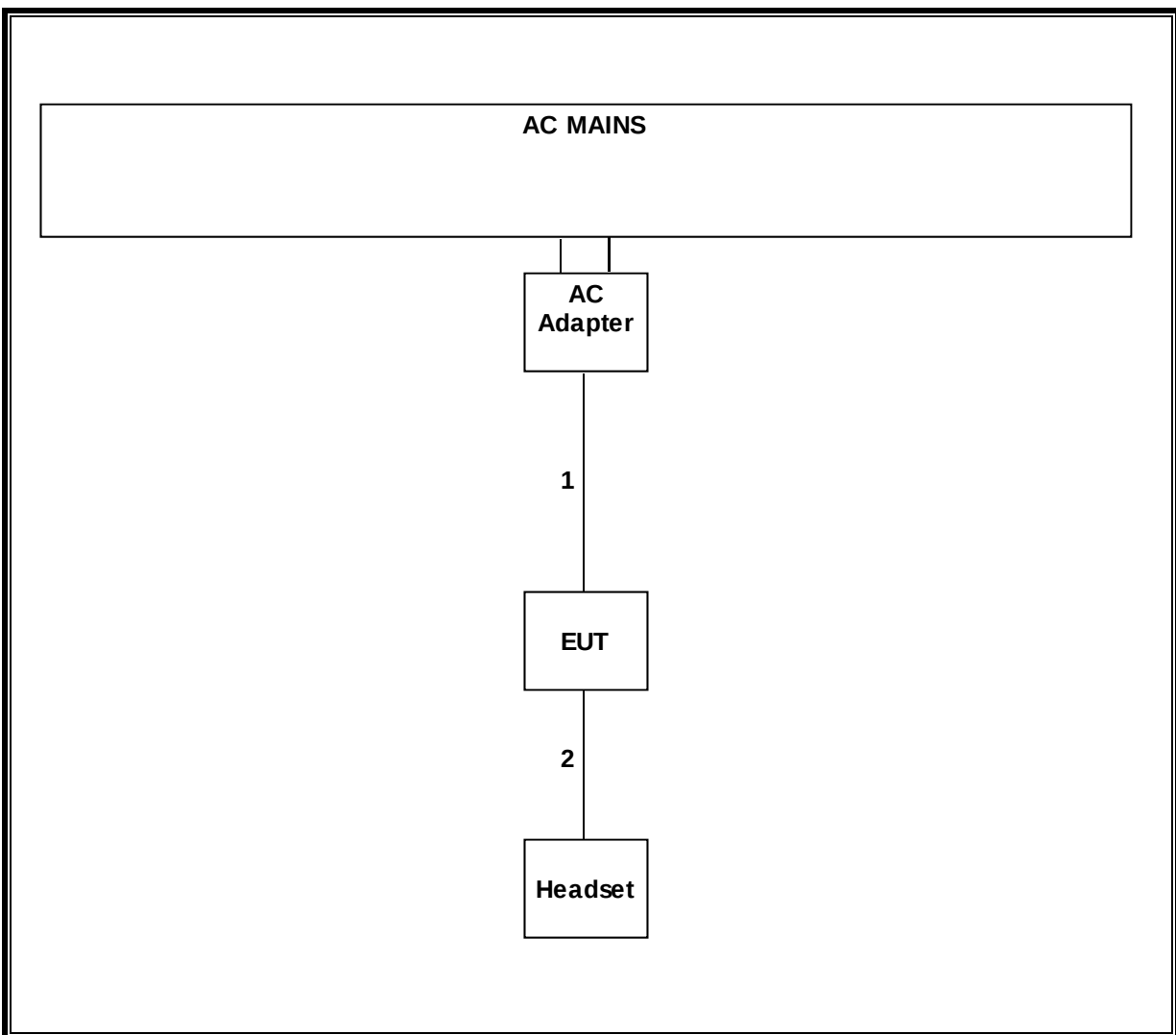
The EUT is a stand-alone device configured and tested in a worst-case setup.

SETUP DIAGRAM FOR TESTS

Radiated Emissions Below 30 MHz:



Radiated Emissions Above 30 MHz, AC Line Conducted Emissions :



6. TEST AND MEASUREMENT EQUIPMENT

The following test and measurement equipment was utilized for the tests documented in this report:

Test Equipment List					
Description	Manufacturer	Model	Asset	Cal Date	Cal Due
ESA-E Spectrum Analyzer, 9kHz-26.5 GHz	Agilent / HP	E4407B	C01098	03/29/13	04/04/14
Antenna, Loop, 30 MHz	EMCO	6502	C00593	02/10/13	02/20/14
Antenna, Bilog, 30MHz-1 GHz	Sunol Sciences	JB1	C01011	03/23/13	03/23/14
Preamplifier, 1300 MHz	Agilent / HP	8447D	C00580	01/21/14	01/21/15
EMI Test Receiver, 30 MHz	R & S	ESHS 20	N02396	08/08/13	08/08/14
LISN, 30 MHz	FCC	50/250-25-2	C00626	01/14/14	01/14/15
DMM	Fluke	77-11	N02303	10/31/13	10/31/14
Digital Thermometer	Tektronix	DTM920	None	05/21/13	10/21/14
Temperature Chamber	CSZ	2PHS-8-3	T267	03/04/13	03/04/14

7. OCCUPIED BANDWIDTH

RULE PART(S)

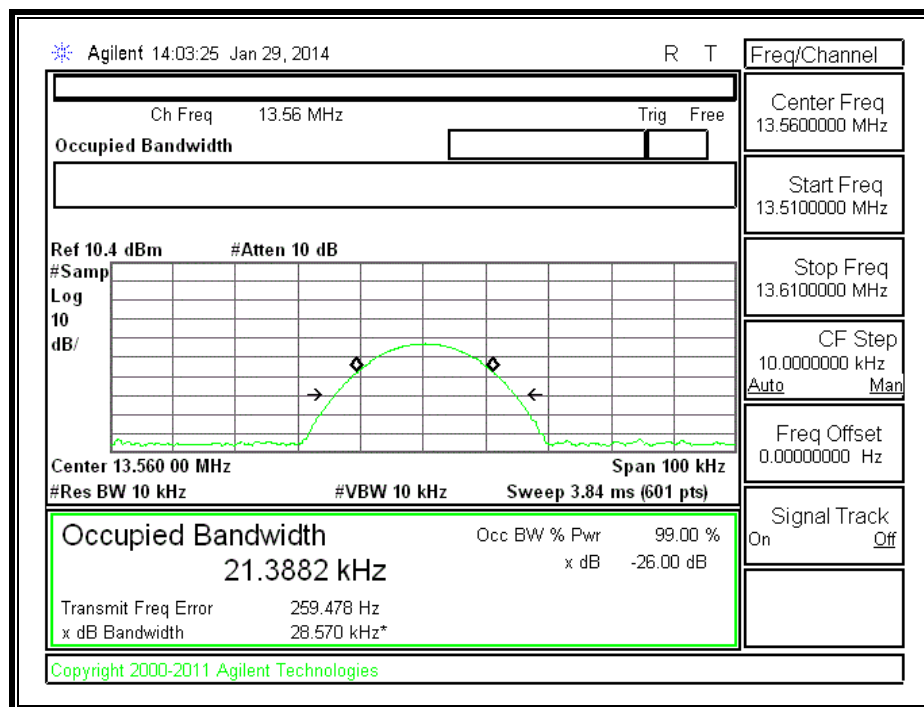
IC RSS 210 Issue 8

LIMITS

For reporting purposes only

RESULTS

Channel	Frequency (KHz)	99% Bandwidth (KHz)
Low	13.56	21.388



8. RADIATED EMISSION TEST RESULTS

8.1. LIMITS AND PROCEDURE

LIMIT

§15.225

IC RSS-210, Annex 2, Section A2.6 (Transmitter)

IC RSS-GEN, Section 6 (Receiver)

(a) The field strength of any emissions within the band 13.553–13.567 MHz shall not exceed 15,848 microvolts/ meter at 30 meters.

(b) Within the bands 13.410–13.553 MHz and 13.567–13.710 MHz, the field strength of any emissions shall not exceed 334 microvolts/meter at 30 meters.

(c) Within the bands 13.110–13.410 MHz and 13.710–14.010 MHz the field strength of any emissions shall not exceed 106 microvolts/meter at 30 meters.

(d) The field strength of any emissions appearing outside of the 13.110– 14.010 MHz and shall not exceed the general radiated emission limits in § 15.209 as follows:

§15.209 (a) Except as provided elsewhere in this subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table:

Limits for radiated disturbance of an intentional radiator		
Frequency range (MHz)	Limits (µV/m)	Measurement Distance (m)
0.009 – 0.490	2400 / F (kHz)	300
0.490 – 1.705	24000 / F (kHz)	30
1.705 – 30.0	30	30
30 – 88	100**	3
88 - 216	150**	3
216 – 960	200**	3
Above 960	500	3

** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g. §§ 15.231 and 15.241.

§15.209 (b) In the emission table above, the tighter limit applies at the band edges.

Formula for converting the field strength from µV/m to dBµV/m is:

Limit (dBµV/m) = 20 log limit (µV/m)

In addition:

§15.209 (d) The emission limits shown the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9-90 kHz, 110-490 kHz and above 1000 MHz. Radiated emissions limits in these three bands are based on measurements employing an average detector.

§15.209 (d) The provisions in §§ 15.225, measuring emissions at distances other than the distances specified in the above table, determining the frequency range over which radiated emissions are to be measured, and limiting peak emissions apply to all devices operated under this part.

TEST PROCEDURE

ANSI C63.4-2009

The EUT is an intentional radiator that incorporates a digital device. The highest fundamental frequency generated or used in the device is 13.56 MHz. The frequency range was investigated from 0.15 MHz to the 10th harmonic of the highest fundamental frequency, or 1000 MHz, whichever is greater (1000MHz)

RESULTS

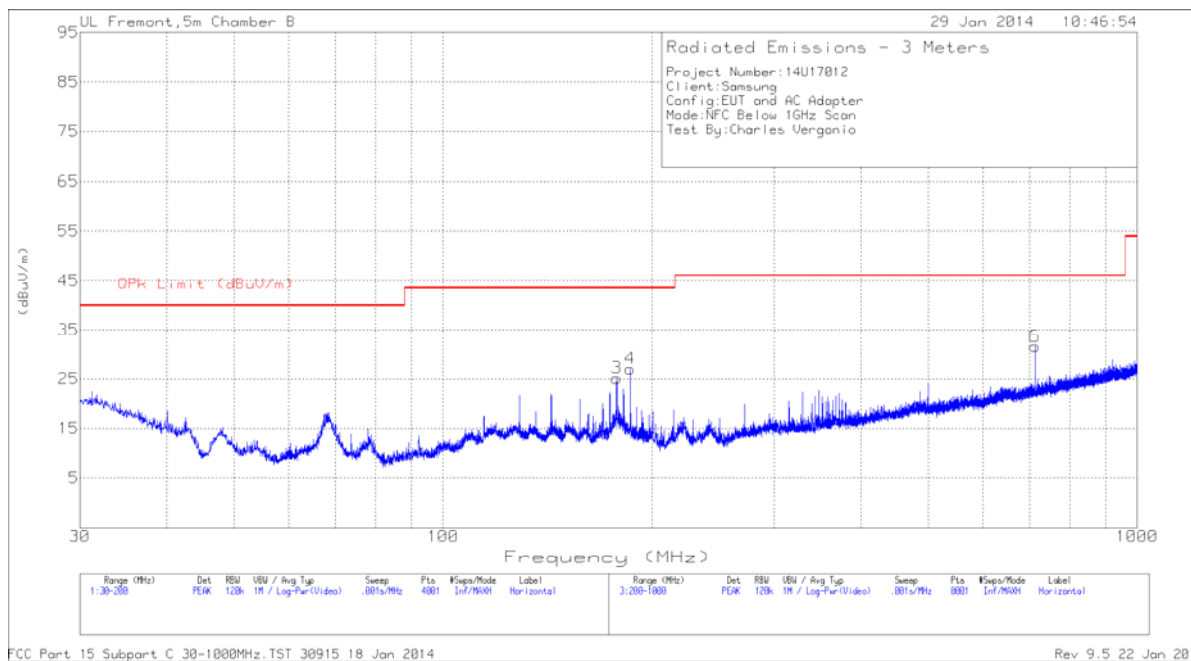
No non-compliance noted:

8.1.1. FUNDAMENTAL AND SPURIOUS EMISSIONS (0.15 – 30 MHz)

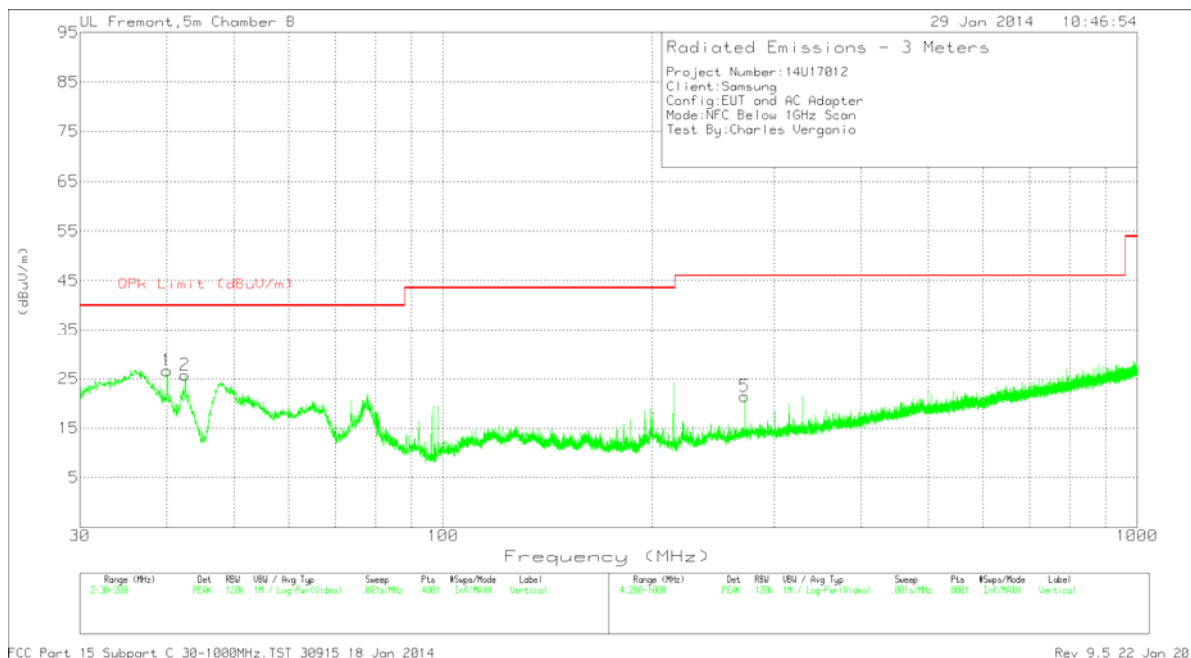
FCC Part 15, Subpart B & C													1 Meter Distance Measurement At Open Field	
Company: Samsung														
Project #: 14U17012														
Model #: SM-N750S														
Tester: R. Alegre														
Date: 1/29/14														
Frequency (MHz)	PK (dBuV)	QP (dBuV)	AV (dBuV)	AF (dB/m)	Distance Correction (dB)	PK Corrected Reading (dBuV/m)	AV Corrected Reading (dBuV/m)	QP Limit (dBuV/m)	AV Limit (dBuV/m)	PK Margin (dB)	AV Margin (dB)	Notes		
Loop Antenna Face on: Y position worst														
13.56	57.1		N/A	10.56	-59.08	8.57	N/A	84.00	N/A	-75.4	N/A	Fundamental @ 1m Dist		
13.44	34.9		N/A	10.54	-59.08	-13.64	N/A	50.48	N/A	-64.1	N/A	13.41MHz-13.553MHz		
13.59	33.71		N/A	10.56	-59.08	-14.82	N/A	50.48	N/A	-65.3	N/A	13.567MHz-13.71MHz		
13.17	31.57		N/A	10.52	-59.08	-17.00	N/A	40.51	N/A	-57.5	N/A	13.110-13.410MHz		
13.77	34.81		N/A	10.52	-59.08	-17.00	N/A	40.51	N/A	-57.5	N/A	13.71-14.01MHz		
7.21	37.35		N/A	10.2	-59.08	-11.53	N/A	29.54	N/A	-41.1	N/A	9k-13.11MHz		
27.08	40.91		N/A	9.05	-59.08	-9.12	N/A	29.54	N/A	-38.7	N/A	14.01MHz-30MHz		
Loop Antenna Face off: Y position														
13.56	48.97		N/A	10.56	-59.08	0.44	N/A	84.00	N/A	-83.6	N/A	Fundamental @ 1m Dist		
13.44	29.49		N/A	10.54	-59.08	-19.05	N/A	50.48	N/A	-69.5	N/A	13.41MHz-13.553MHz		
13.59	30.72		N/A	10.56	-59.08	-17.81	N/A	50.48	N/A	-68.3	N/A	13.567MHz-13.71MHz		
13.17	30.26		N/A	10.52	-59.08	-18.31	N/A	40.51	N/A	-58.8	N/A	13.110-13.410MHz		
13.77	34.12		N/A	10.58	-59.08	-14.39	N/A	40.51	N/A	-54.9	N/A	13.71-14.01MHz		
7.21	34.56		N/A	10.2	-59.08	-14.32	N/A	29.54	N/A	-43.9	N/A	9k-13.11MHz		
27.10	37.37		N/A	9.048	-59.08	-12.67	N/A	29.54	N/A	-42.2	N/A	14.01MHz-30MHz		
* No more emissions were found up to 30MHz														
Note: The emission limits are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9–90 kHz, 110–490 kHz and above 10000Mhz. Radiated emission limits in these three bands are based on measurements employing an average detector.														
P.K. = Peak														
Q.P. = Quasi Peak Reading														
A.F. = Antenna factor														
Rev. 10.23.09														

8.1.2. TX SPURIOUS EMISSION 30 TO 1000 MHz

EMI PLOT



EMI PLOT



DATA

Trace Markers

Marker	Frequency (MHz)	Meter Reading (dBuV)	Det	AF T243 (dB/m)	Amp/Cbl (dB)	Corrected Reading (dBuV/m)	QPk Limit (dBuV/m)	Margin (dB)	Azimuth (Degs)	Height (cm)	Polarity
5	* 272	34.42	PK	13.3	-26.3	21.42	46.02	-24.6	0-360	101	V
1	40.03	41.82	PK	13.5	-28.7	26.62	40	-13.38	0-360	101	V
2	42.495	42.71	PK	11.7	-28.7	25.71	40	-14.29	0-360	101	V
3	177.9425	41.35	PK	11	-27.2	25.15	43.52	-18.37	0-360	200	H
4	186.1025	43.13	PK	11	-27.1	27.03	43.52	-16.49	0-360	100	H
6	712.7	35.86	PK	20.3	-24.6	31.56	46.02	-14.46	0-360	200	H

* - indicates frequency in CFR15.205/IC7.2.2 Restricted Band

PK - Peak detector

9. AC MAINS LINE CONDUCTED EMISSIONS

LIMITS

§15.207

IC RSS-GEN, Section 7.2.2

(a) Except as shown in paragraphs (b) and (c) of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 μ H/50 ohms line impedance stabilization network (LISN). Compliance with the provisions of this paragraph shall be based on the measurement of the radio frequency voltage between each power line and ground at the power terminal. The lower limit applies at the band edges.

Frequency range (MHz)	Limits (dB μ V)	
	Quasi-peak	Average
0.15 to 0.50	66 to 56	56 to 46
0.50 to 5	56	46
5 to 30	60	50

Notes:
1. The lower limit shall apply at the transition frequencies
2. The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50 MHz.

TEST PROCEDURE

ANSI C63.4-2009

RESULTS

No non-compliance noted:

6 WORST EMISSIONS

Line-L1 .15 - 30MHz

Trace Markers										
Marker	Frequency (MHz)	Meter Reading (dBuV)	Det	T24 IL L1 (dB)	LC Cables 1&3 (dB)	Corrected Reading dB(uVolts)	CISPR 11/22 Class B Quasi-peak	Margin to Limit (dB)	CISPR 11/22 Class B Average	Margin to Limit (dB)
1	.1725	49.57	PK	1.2	0	50.77	64.8	-14.03	-	-
2	.1725	36.29	Av	1.2	0	37.49	-	-	54.8	-17.31
3	.861	48.45	PK	.3	0	48.75	56	-7.25	-	-
4	.861	32.24	Av	.3	0	32.54	-	-	46	-13.46
5	2.1525	44.57	PK	.2	.1	44.87	56	-11.13	-	-
6	2.1525	24.84	Av	.2	.1	25.14	-	-	46	-20.86
7	14.1	47.54	PK	.2	.2	47.94	60	-12.06	-	-
8	14.1	29.77	Av	.2	.2	30.17	-	-	50	-19.83

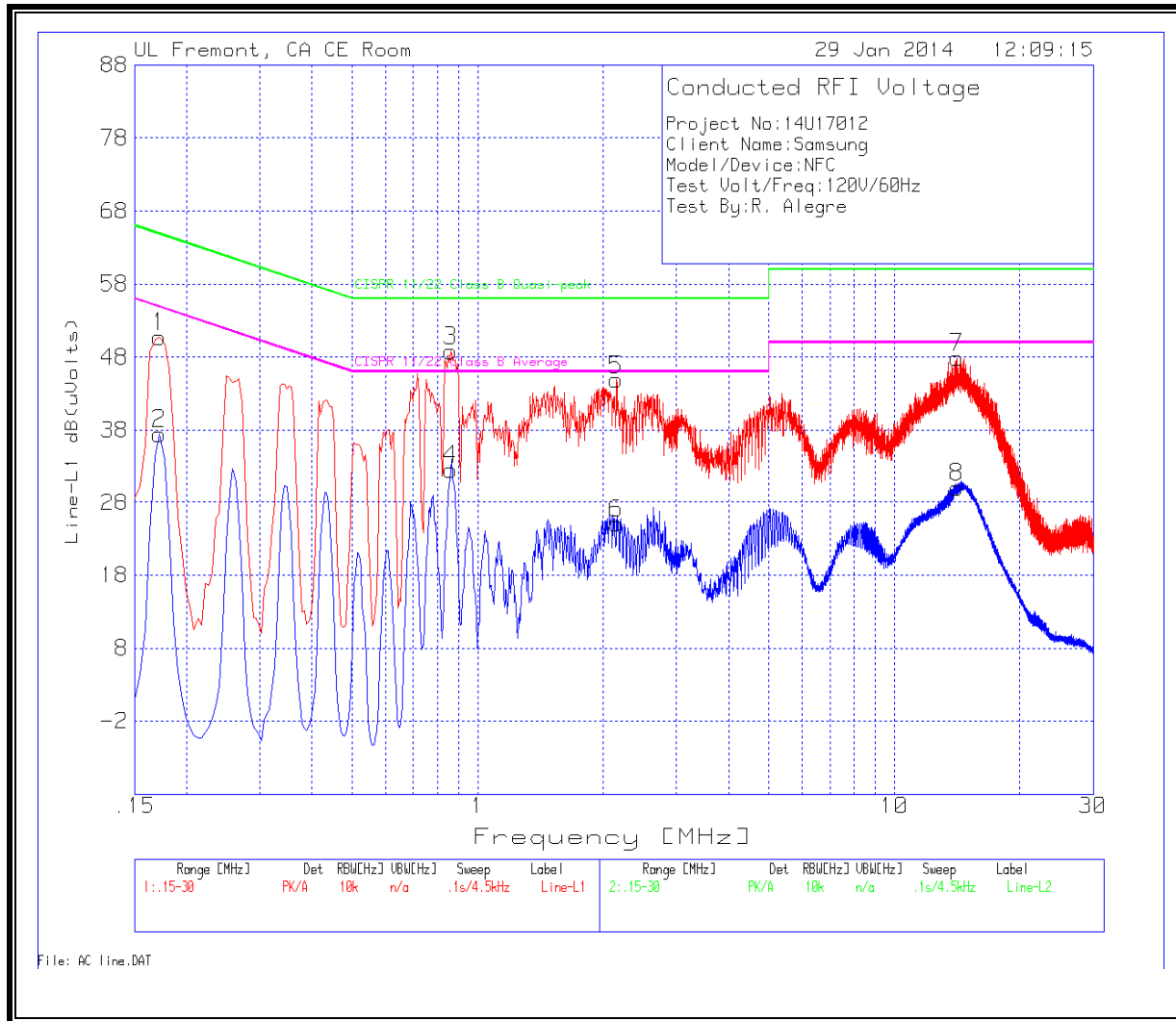
Line-L2 .15 - 30MHz

Trace Markers										
Marker	Frequency (MHz)	Meter Reading (dBuV)	Det	T24 IL L2 (dB)	LC Cables 2&3 (dB)	Corrected Reading dB(uVolts)	CISPR 11/22 Class B Quasi-peak	Margin to Limit (dB)	CISPR 11/22 Class B Average	Margin to Limit (dB)
9	.1725	43.29	PK	1.2	0	44.49	64.8	-20.31	-	-
10	.1725	29.68	Av	1.2	0	30.88	-	-	54.8	-23.92
11	.8385	45.96	PK	.3	.1	46.36	56	-9.64	-	-
12	.8385	20.08	Av	.3	.1	20.48	-	-	46	-25.52
13	1.932	40.97	PK	.2	.1	41.27	56	-14.73	-	-
14	1.932	19.84	Av	.2	.1	20.14	-	-	46	-25.86
15	14.1	44.82	PK	.3	.2	45.32	60	-14.68	-	-
16	14.1	29.41	Av	.3	.2	29.91	-	-	50	-20.09

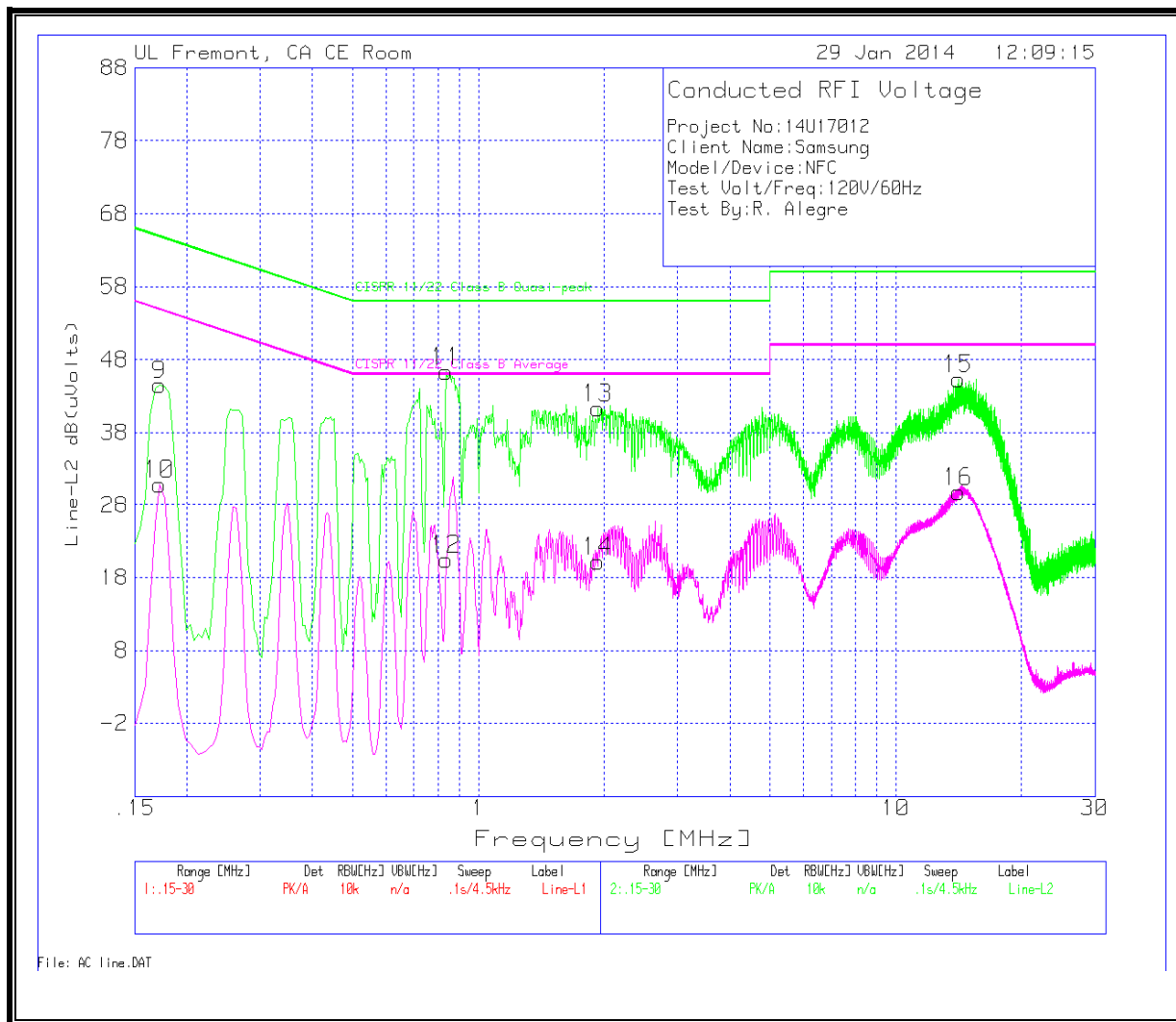
PK - Peak detector

Av - average detection

LINE 1 RESULTS



LINE 2 RESULTS



10. FREQUENCY STABILITY

LIMIT

§15.225 (e) The frequency tolerance of the carrier signal shall be maintained within $\pm 0.01\%$ of the operating frequency, over a temperature variation of -20 degrees to +50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C. For battery operated equipment, the equipment tests shall be performed using a new battery.

TEST PROCEDURE

ANSI C63.4 Section 13

RESULTS

No non-compliance noted.

Reference Frequency: EUT Channel 13.560000 MHz @ 20°C				
Limit: ± 100 ppm = 135.577 kHz				
Power Supply (Vdc)	Environment Temperature (°C)	Frequency Deviation Measured with Time Elapse		
		(MHz)	Delta (ppm)	Limit (ppm)
3.70	50	13.5575000	0.133	± 100
3.70	40	13.5578700	-0.140	± 100
3.70	30	13.5576000	0.059	± 100
3.70	20	13.5576800	0.000	± 100
3.70	10	13.5578000	-0.089	± 100
3.70	0	13.5578500	-0.125	± 100
3.70	-10	13.5578400	-0.118	± 100
3.70	-20	13.5579000	-0.162	± 100
3.30	20	13.5578600	-0.133	± 100
4.2	20	13.5580100	-0.243	± 100